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Help

1) Enter a single keyword, phrase, or Boolean expression.
Example: acoustic imaging (means the phrase acoustic imaging plus any stem variations)
2) Limit your search by using search operators and field codes, if desired.
Example: optical <and> (fiber <or> fibre) <in> ti
3) Limit the results by selecting Search Options.
4) Click Search. See Search Examples

```
(cross*bar* <or> (cross*
<near/1> bar*) <or> xbar*)
<and> (multiplex* <or> mux*)
```

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Note: This function returns plural and suffixed forms of the keyword(s).

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